ABSTRACT
In higher power applications to utilize the full line power and reduce line current harmonics PFC Pre-regulators are generally required. In these high power applications interleaving PFC stages can reduce inductor volume and reduce input and output capacitor ripple current. This results in smaller overall magnetic volume and filter capacitor volume increasing the converters overall power density. This is made possible through distributing the power over two interleaved boost converters and the inductor ripple current cancellation that occurs with interleaving, reference [5]. This application note will review the design of a 300W two-phase interleaved power factor corrected (PFC) pre-regulator. This power converter achieves PFC with the use of the UCC28070 interleaved PFC controller, reference [7].

1 Design Goals
The specifications for this design were chosen based on the power requirements of a medium power LCD TV.

Table 1. Design Specifications

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{IN}$ RMS input voltage</td>
<td>85</td>
<td>265</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>$V_{OUT}$ Output voltage</td>
<td>390</td>
<td></td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Line frequency</td>
<td>47 Hz</td>
<td>63 Hz</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$P_{OUT}$ Output power</td>
<td>0.90</td>
<td></td>
<td>W</td>
<td></td>
</tr>
<tr>
<td>$\eta$ Full load efficiency</td>
<td>90%</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$f_s$ Individual phase switching frequency</td>
<td>200 kHz</td>
<td></td>
<td>kHz</td>
<td></td>
</tr>
</tbody>
</table>
UCC28070 PFC controller in a two-phase average current mode control interleaved PFC pre-regulator.

Figure 1. Typical Average Current Mode Interleaved PFC Pre-Regulator
3 Inductor Selection

One of the benefits of interleaved PFC boost pre-regulators is inductor ripple current reduction that is seen at the input of the converter. The following equations and Figure 2 show the ratio of input ripple current ($\Delta I_{IN}$) to individual inductor ripple current ($\Delta I_{L1}$) in a two-phase interleaved PFC as a function of duty cycle ($D$). Because of this inductor ripple current cancellation, the designer can allow each inductor to have more inductor ripple current than in a single stage design.

$$K(D) = \frac{\Delta I_{IN}}{\Delta I_{L1}}$$  

$$K(D) = \frac{1-2D}{1-D} \text{ if } D < 0.5 = 0.5$$  

$$K(D) = \frac{2D-1}{D} \text{ if } D > 0.5$$

Figure 2. Input Inductor Ripple Current Cancellation

The boost inductors (L1 and L2) are selected based on the maximum allowable input ripple current. In universal applications (e.g., 85 V to 265 V RMS input) the maximum input ripple current occurs at the peak of low line and for this design the maximum input ripple current was set to 30% of the peak nominal input current at low line.
The following calculations are used to select the appropriate inductance for L1 and L2. Where, variable $D_{PLL}$ is the converter’s duty cycle at the peak of low line operation. Variable $K(D_{PLL})$ is the ratio of input current to inductor ripple current at the peak of low line operation. $\Delta I_L$ is the boost inductor ripple current at the peak of low line based on the converters input ripple current requirements.

$$D_{PLL} = \frac{V_{OUT} - V_{IN\_MIN} \sqrt{2}}{V_{OUT}} = \frac{390V - 85V\sqrt{2}}{390V} \approx 0.69$$

(4)

$$K(D_{PLL}) = \frac{2 \times 0.69 - 1}{0.69} = 0.55$$

(5)

$$\Delta I_L = \frac{P_{OUT} \times \sqrt{2} \times 0.3}{V_{IN\_MIN} \times \eta \times K(D_{PLL})} = \frac{300W \times \sqrt{2} \times 0.3}{85V \times 0.90 \times 0.55} \approx 3.0 \text{ A}$$

(6)

$$L1 = L2 = \frac{V_{IN\_MIN} \times \sqrt{2} \times D_{PLL}}{\Delta I_L \times f_s} = \frac{85V \times \sqrt{2} \times 0.69}{2.96A \times 200 \text{ kHz}} \approx 140 \mu \text{H}$$

(7)

The following equation can be used to calculate total inductor RMS current ($I_{L1\_RMS}$ and $I_{L2\_RMS}$).

$$I_{L1\_RMS} = I_{L2\_RMS} = \left( \frac{P_{OUT}}{2} \right)^2 \left( \frac{\sqrt{2} \times V_{IN\_MIN} \sin(\theta) \times V_{OUT} - V_{IN\_MIN} \sqrt{2} \sin(\theta)}{L1 \times f_s} \right)^2 + \frac{1}{12}$$

(8)

$$I_{L1\_RMS} = I_{L2\_RMS} = \left( \frac{300W}{2} \right)^2 \left( \frac{85V \sqrt{2} \sin(\theta)}{140\mu \text{H} \times 200 \text{ kHz}} \times \frac{390V - 85V \sqrt{2} \sin(\theta)}{390V} \right)^2$$

(9)

A 140-μH boost inductor from Cooper Electronic Technologies part number CTX16-18060 was chosen for the design. The inductance during normal operation will swing from 140μH to 350μH.

$$L1_{MIN} = L2_{MIN} = 140 \mu \text{H}$$

(10)

$$L1_{MAX} = L2_{MAX} = 350 \mu \text{H}$$

The average inductance is calculated for current loop compensation purposes. This will be used in the current loop compensation section of the application note:

$$L1_{AVG} = L2_{AVG} = \frac{L1_{MIN} + L1_{MAX}}{2} = \frac{140 \mu \text{H} + 350 \mu \text{H}}{2} = 245 \mu \text{H}$$
Output Capacitor Selection

The output capacitor \( C_{\text{OUT}} \) is selected based on holdup requirements.

\[
C_{\text{OUT}} \geq \frac{2 \times P_{\text{OUT}}}{\eta V_{\text{OUT}}^2 - (V_{\text{OUT}} \times 0.75)^2} = \frac{2 \times 300 \text{W}}{47 \text{ Hz}} = 192 \mu \text{F}
\]  

(11)

Two 100-\( \mu \)F capacitors were used in parallel for the output capacitor.

\[
C_{\text{OUT}} = 200 \mu \text{F}
\]  

(12)

For this size capacitor the output peak to peak voltage ripple \( V_{\text{RIPPLE}} \) is:

\[
V_{\text{RIPPLE}} = \frac{2 \times P_{\text{OUT}}}{\eta V_{\text{OUT}} \times 2\pi \times 2/\text{LINE} \times C_{\text{OUT}}} = \frac{2 \times 300 \text{W}}{0.90 \times 390 \text{V} \times 2 \times 47 \text{Hz} \times 200 \mu \text{F}} \approx 14.5 \text{V}
\]  

(13)

In addition to holdup requirements, a capacitor must be selected so that it can withstand both the low-frequency RMS current \( I_{\text{COUT,LF}} \) and the high-frequency RMS current \( I_{\text{COUT, HF}} \). High-voltage electrolytic capacitors generally have both low frequency (100 Hz to 120 Hz) and high frequency RMS current ratings on their data sheets.

\[
I_{\text{COUT,LF}} = \frac{P_{\text{OUT}}}{\eta V_{\text{OUT}} \sqrt{2}} = \frac{300 \text{W}}{0.90 \times 390 \text{V} \times \sqrt{2}} \approx 0.604 \text{A}
\]  

(14)

\[
I_{\text{COUT, HF}} = \left[ \frac{P_{\text{OUT}}}{\eta V_{\text{OUT}} \sqrt{6\pi \times V_{\text{IN, MIN}} \sqrt{2}}} \right]^2 - I_{\text{COUT, LF}}^2
\]  

(15)

\[
I_{\text{COUT, HF}} = \left[ \frac{300 \text{W}}{0.90 \times 390 \text{V} \sqrt{6\pi \times 85 \sqrt{2}}} \right]^2 - (0.604)^2 \approx 1.0 \text{A}
\]  

(16)
5 Power Semiconductor Selection (Q1, Q2, D1, D2)

The selection of Q1, Q2, D1, and D2 are based on the power requirements of the design. Application note (SLUA369), UCC28528 350-W Two Phase Interleaved PFC Pre-regulator, explains how to select power semiconductor components for interleaved PFC pre-regulators using average current mode control techniques, reference [4]. To meet the power requirements of this design IRFB11N50A N channel FETs from IR were chosen for Q1 and Q2. To reduce reverse recovery losses SiC diodes CSD10060G from CREE were chosen for the design.

Boost Diode (D1, D2) and FET (Q1, Q2) peak current (I_{PEAK}) calculation:

A factor of 1.2 was added to the equation for added design margin.

\[
I_{PEAK} = \left( \frac{P_{OUT} \times \sqrt{2}}{2 \times V_{IN_{MIN}} \times \eta} + \frac{L_L}{2} \right) 1.2 = \left( \frac{300W \times \sqrt{2}}{2 \times 85V \times 0.90} + \frac{2.97A}{2} \right) 1.2 \approx 5.1A
\]  

(17)

Q1 and Q2 RMS current (I_{DS}) calculation:

\[
I_{DS} = \frac{P_{OUT}}{\eta} \times \frac{2}{2 \times V_{IN_{MIN}} \sqrt{2}} \times \left( \frac{16 \times V_{IN_{MIN}} \sqrt{2}}{3 \times \pi \times V_{OUT}} \right) = \frac{300W}{0.90} \times \frac{2}{2 \times 85V \sqrt{2}} \times \left( \frac{16 \times 85V \sqrt{2}}{3 \times \pi \times 390V} \right) \approx 1.685A
\]  

(18)

D1 and D2’s average current calculation (I_b):

\[
I_b = \frac{P_{OUT}}{V_{OUT}} = \frac{300W}{2 \times 390V} \approx 0.39A
\]  

(19)
6 Current Sense Transformers Setup and Selection (T1, T2, DRA, DRB)

The current sense transformer is selected to handle I_{PEAK} and have a peak current sense signal (I_{RS}) of roughly 100 mA.

\[
N_{CT} = \frac{N_S}{N_P} \geq \frac{I_{PEAK}}{I_{RS}} = \frac{5.1\text{A}}{0.1\text{A}} = 51
\]

(20)

For this design a current sense transformer with a turns ratio (N_{CT}) of 50 was chosen for the design.

\[
N_{CT} = 50
\]

(21)

The magnetizing inductance (L_M) of the current sense transformer should be selected or designed so the magnetizing current is less than 2% of the maximum current sense signal. The following equation calculates the minimum L_M where V_S is the maximum current sense signal voltage. For this design a current sense transformer was designed by Cooper Electronic Technologies (CTX16-18294) with a magnetizing inductance of 8.25 mH.

\[
L_M \geq \frac{V_S}{I_{PEAK}} \times \frac{V_{OUT} - V_{IN_MIN} \sqrt{2}}{V_{OUT}} \times \frac{3.7V}{0.02 \times 200kHz} \times \frac{390V - 85V \sqrt{2}}{50} \approx 6.24\text{mH}
\]

(22)

\[
L_M = 8.25 \text{ mH}
\]

(23)

Selection of the current sense resistors (R_{SA} and R_{SB}) is based on the peak current limit signal (V_S) and the peak current on the secondary side of the current sense transformer. A factor of 0.9 was multiplied by the current sense signal to leave room for the 10% PWM ramp that is used to make this design more noise immune at lighter loads.

\[
R_{SA} = R_{SB} = \frac{0.9 \times V_S}{I_{PEAK}} \times \frac{0.9 \times 3.7V \times 50}{0.102A} \approx 32.5 \Omega
\]

(24)

Select a standard resistor for the design:

\[
R_S = 33.2 \Omega
\]

(25)

Resistor R_{R} is used to reset the current sense transformer:

\[
R_R \geq R_S \times D_{MAX} = \frac{33.2 \Omega \times 0.97}{1 - 0.97} = 1 \text{k}\Omega
\]

(26)

Current sense transformer’s rectifying diodes (D_R) need to be designed to withstand the current sense transformers reset voltage (V_R):

\[
V_R = I_{PEAK} \times \frac{N_P}{N_S} \times R_R = \frac{5.1\text{A} \times 1 \text{k}\Omega}{50} \geq 103\text{V}
\]

(27)
To improve noise immunity at extremely light loads, a PWM ramp with a dc offset is recommended to be added to the current sense signals. Electrical components $R_{TA}$, $R_{TB}$, $C_{TA}$, $C_{TB}$, $D_{PA1}$, $D_{PA2}$, $D_{PB1}$, and $D_{PB2}$ form a PWM ramp that is activated and deactivated by the gate drive outputs of the UCC28070. Resistor $R_{OA}$ and $R_{OB}$ add a DC offset to the CS resistors ($R_{SA}$ and $R_{SB}$).

When the inductor current becomes discontinuous the boost inductors ring with the parasitic capacitances in the boost stages. This inductor current rings through the CTs causing a false current sense signal. Refer to the following graphical representation of what the current sense signal looks like when the inductor current goes discontinuous. Note that the inductor current and $V_{RSA}$ may vary from this graphical representation depending on how much inductor ringing is in the design when the unit goes discontinuous.

![Graphical representation of current sense signal](image-url)

**Figure 3. False Current Sense Signal**
To properly select the offset ($V_{\text{OFF}}$) just requires adjusting resistors $R_{OA}$ and $R_{OB}$ to add a dc offset to the current sense resistors, that is high enough to block $D_{RA}$ and $D_{RB}$ from conducting when a false current sense signals is present. This occurs when the inductors are operating with discontinuous inductor current and was described above in detail. Setting the offset to 200 mV is a good starting point and may need to be adjusted based on individual design criteria and the amount of noise and parasitic elements present in the system.

$$V_{\text{OFF}} = 0.2 \text{ V}$$

$$R_{OA} = R_{OB} = \frac{(V_{\text{VCC}} - V_{\text{OFF}})R_{SA}}{V_{\text{OFF}}} = \frac{(13\text{V} - 0.2\text{V}) \times 33.2}{0.2\text{V}} \approx 2.1 \text{ k}\Omega$$

(28)

(29)

Select a standard resistor for the design:

$$R_{OA} = 2.05 \text{ k}\Omega$$

(30)

$$R_{TA} = R_{TB} = \frac{(V_{\text{VCC}} - (V_s \times 0.1 - V_{\text{OFF}} + V_{\text{DPA2}})R_{SA}}{V_s \times 0.1 - V_{\text{OFF}}} = \frac{(13\text{V} - (3.7\text{V} \times 0.1 - 0.2\text{V}) + 0.6\text{V}) \times 33.2}{3.7\text{V} \times 0.1 - 0.2\text{V}} \approx 2.62 \text{ k}\Omega$$

(31)

Chose a standard resistor for the design:

$$R_{TA} = R_{TB} = 2.49 \text{ k}\Omega$$

(32)

$$C_{TA} = \frac{1}{R_{SA} \times f_s \times 3} \approx 50 \text{ nF}$$

(33)

A standard capacitor needs to be chosen for the design:

$$C_{TA} = 47 \text{ nF}$$

(34)
7 Setting Up Peak Current Limiting (RPK1, RPK2)

The UCC28070 has an adjustable peak current limit comparator that can be set up by selecting $R_{PK1}$ and calculating the required $R_{PK2}$. For this design to keep the reset voltage of the current sense transformer manageable the peak current sense signal ($V_S$) was set to 3.7 V.

$$R_{PK2} = \frac{V_S \times R_{PK1}}{V_{REF} - V_S} = \frac{3.7V \times 3.65 \text{ k}\Omega}{6V - 3.7V} \approx 5.9 \text{ k}\Omega$$  \hspace{1cm} (35)

**Converter Timing and Maximum Duty Cycle Clamp**

Resistor $R_{RT}$ and $R_{DMX}$ set up converter timing and the maximum PWM duty cycle clamp:

$$R_{RT} = \frac{7.5 \times 10^9 \Omega \times \text{Hz}}{f_s} = \frac{7.5 \times 10^9 \Omega \times \text{Hz}}{200 \text{ kHz}} = 37.5 \text{ k}\Omega$$  \hspace{1cm} (36)

A standard resistor was selected for the design:

$$R_{RT} = 37.4 \text{ k}\Omega$$  \hspace{1cm} (37)

Resistor $R_{DMX}$ was selected to set the maximum duty cycle clamp ($D_{MAX}$) to 0.97:

$$R_{DMX} = R_{RT} (2 \times D_{MAX} - 1) = 37.4 \text{ k}\Omega (2 \times 0.97 - 1) = 35 \text{ k}\Omega$$  \hspace{1cm} (38)

Chose a standard resistor for the design:

$$R_{DMX} = 34.8 \text{ k}\Omega$$  \hspace{1cm} (39)

8 Programming VOUT

Resistor $R_A$ is selected to minimize the error due to VSENSE input bias current and to minimize loading on the power line when the PFC is disabled. Construct resistor $R_A$ from two or more resistors in series to meet high voltage requirements. Resistor $R_B$ is sized to program the converter's output voltage ($V_{OUT}$).

$$R_A = 3M\Omega$$  \hspace{1cm} (40)

$$R_B = \frac{V_{REF}}{2} \times \frac{R_A}{V_{OUT} - \frac{V_{REF}}{2}} = \frac{3V \times 3M\Omega}{390V - 3V} \approx 23.3 \text{ k}\Omega$$  \hspace{1cm} (41)

A standard resistor was chosen for the design.

$$R_B = 23.2 \text{ k}\Omega$$  \hspace{1cm} (42)

The resistor divider formed by $R_A$ and $R_B$ from the output voltage to the VSENSE pin also sets the over voltage protection threshold ($V_{OVP}$).

$$V_{OVP} = 3.18V \frac{R_A + R_B}{R_B} = 3.18V \frac{3M\Omega + 23.2 \text{ k}\Omega}{23.2 \text{ k}\Omega} \approx 414V$$  \hspace{1cm} (43)
9 VINAC Divider Setup

The UCC28070 also requires sensing the line input for proper operation. This requires a divider from the rectified line voltage to the VINAC pin of the UCC28070. For simplicity the UCC28070 was designed to use the same resistor divider values as the VSENSE pin. Resistors \( R_A \) and \( R_B \) need to be the same ratio for the VINAC voltage divider as that in the VSENSE voltage divider to ensure the UCC28070 controller operates correctly. Please refer to the applications schematic for proper component placement.

10 Voltage Loop Configuration

The methodology used to compensate the voltage loop is based on the compensation methodology developed by Lloyd Dixon. A detailed explanation of this compensation scheme written by Mr. Dixon can be found in the 1990 Unitrode Power Supply Design SEM700, High Power Factor Switching Pre-regulator Design Optimization, Topic 7, reference [2].

Capacitor \( C_{PV} \) is sized to attenuate low frequency ripple to less than 3% of the voltage amplifier output range. This will ensure good power factor and low input current harmonic distortion.

Voltage Amplifier Transconductance Amplifier gain:

\[
gm_V = 70 \ \mu \text{S}
\]  

Voltage Divider Feedback Gain:

\[
H = \frac{V_{VREF}}{V_{OUT}} = \frac{3V}{390V} \approx 0.0077
\]  

Output impedance \( (Z_o) \) is required to attenuate the low frequency boost capacitor output ripple \( (V_{RIPPLE}) \) to less than 3% of the effective voltage amplifier output range \( (\Delta V_{AO}) \). This impedance is set by properly selecting feedback capacitor \( C_{PV} \):

\[
Z_o = \frac{\Delta V_{AO} \times 0.03}{V_{RIPPLE} \times H \times gm_V} = \frac{3.2V \times 0.03}{14.5V \times 0.0077 \times 70 \ \mu \text{S}} \approx 12.3 \ \text{k\Omega}
\]

\[
C_{PV} = \frac{1}{2\pi \times 2 \times f_{LINE} \times Z_o} = \frac{1}{2\pi \times 2 \times 47Hz \times 12.3k\Omega} \approx 138nF
\]  

Choose as standard capacitor for the design:

\[
C_{PV} = 150 \ \text{nF}
\]
Voltage Loop Configuration

For the highest possible power factor the voltage loop crossover frequency \( f_{CV} \) needs to be set based on the following equation:

\[
\Delta VAO = 3.2 \text{ V}
\]

\[
f_{CV} = H \times g_{mV} \times \frac{P_{OUT}}{\Delta VAO} \times \frac{1}{V_{OUT}} \times \frac{j \times 2\pi \times C_{OUT}}{\frac{1}{2 \times \pi \times C_{PV}}}
\]

(49)

\[
f_{CV} = \sqrt{\frac{300W \times 0.0077 \times 70\mu\text{S} \times \frac{0.90}{3.2V}}{2\times\pi\times200\mu\text{F}\times390\text{V}}} \times \frac{1}{2\times\pi\times150\text{nF}} \approx 11\text{Hz}
\]

(50)

Voltage compensation resistor \( R_{ZV} \) is then sized to put a pole at the converter’s voltage loop crossover frequency:

\[
R_{ZV} = \frac{1}{2\pi \times f_{CV} \times C_{PV}} = \frac{1}{2\pi \times 10.6\text{Hz} \times 150\text{nF}} \approx 96.4 \text{ k}\Omega
\]

(51)

Select a standard resistor for the design:

\[
R_{ZV} = 100 \text{ k}\Omega
\]

(52)

Voltage compensation capacitor \( C_{ZV} \) is used to increase the dc gain of the voltage loop and gives some added phase margin before crossover. The zero added to the voltage loop needs to be set at 1/10th the crossover frequency.

\[
C_{ZV} = \frac{1}{2\pi \times \frac{f_{CV}}{10} \times R_{ZV}} = \frac{1}{2\pi \times \frac{11\text{Hz}}{10} \times 100 \text{ k}\Omega} \approx 1.5 \text{ \mu F}
\]

(54)
The following equations can be used to estimate voltage compensation network gain, voltage loop power stage gain and voltage loop gain. These equations can also be used to graphically check loop stability.

Voltage Compensation Network Gain \( (G_{CV}(f)) \) as function of frequency:

\[
G_{CV}(f) = \frac{\Delta V_{VAO}}{\Delta V_{OUT}} = H \times \text{gm}_V \times \frac{j \times 2\pi \times f \times R_{ZV} \times C_{ZV} + 1}{(j \times 2\pi \times f \times (C_{ZV} + C_{PV}))} \left( \frac{j \times 2\pi \times f \times R_{ZV} \times C_{ZV} \times C_{PV} + 1}{C_{ZV} + C_{PV}} \right)
\]

Voltage Loop Power Stage Gain \( (G_{PSV}(f)) \) as function of frequency:

\[
G_{PSV}(f) = \frac{\Delta V_{OUT}}{\Delta V_{VAO}} = \frac{P_{OUT}}{\eta} \times \frac{1}{V_{OUT}} \left( \frac{j \times 2\pi \times f \times C_{OUT}}{1} \right)
\]

Voltage Loop Gain in dB \( (TvdB(f)) \) as function of frequency:

\[
TvdB(f) = 20\log \left( |G_{PSV}(f) \times G_{CV}(f)| \right)
\]

Figure 4 shows the theoretical loop gain \( (TvdB(f)) \) as a function of frequency and Figure 5 shows the theoretical loop phase \( (\theta v(f)) \) as a function of frequency. From these figures it can be observed that the voltage loop crossed over at roughly 9 Hz with a phase margin of 60 degrees. Compensating the voltage loop is not an exact science and should be checked with a network analyzer and adjusted if necessary.

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**Figure 4.** Theoretical Voltage Loop Gain \( (TvdB(f)) \)

**Figure 5.** Theoretical Voltage Loop Phase \( (\theta v(f)) \)
11 Current Loop Compensation

Setting up the current synthesizer is accomplished by correctly selecting \( R_{\text{SYN}} \):

The inductor used in this design example swings from 350 \( \mu \text{H} \) to 140 \( \mu \text{H} \) from no load to maximum load. When calculating \( R_{\text{SYN}} \) the highest inductance value (\( L_{\text{MAX}} \)) should be used.

\[
R_{\text{SYN}} = \frac{N_{\text{CT}} \times L_{\text{MAX}}}{R_s \times 0.1 \text{nF}} \frac{R_B}{R_A + R_B} = \frac{50 \times 350 \, \mu \text{H} \times 23.2 \, \text{k}\Omega}{33.2 \, \Omega \times 0.1 \text{nF} + 3 \, \text{M}\Omega + 23.2 \, \text{k}\Omega} \approx 40.5 \, \text{k}\Omega
\]  

(58)

Chose a standard resistor:

\[ R_{\text{SYN}} = 38.3 \, \text{k}\Omega \]  

(59)

The IMO resistor needs to be set with the following equation to center the digitized multiplier for universal line applications:

\[
IMO = \frac{17 \times 10^{-6} \text{A} \times V_{\text{INAC}} (V_{\text{VAOMAX}} - 1 \text{V})}{K_{\text{VFF}}} = \frac{17 \times 10^{-6} \text{A} \times 0.76V (5V - 1 \text{V})}{0.398V^2} \approx 130 \, \mu \text{A}
\]  

(60)

\[
V_i = \frac{0.76V \times (R_A + R_B)}{R_B \times \sqrt{2}} = \frac{0.76V \times (3 \, \text{M}\Omega + 23.2 \, \text{k}\Omega)}{23.2 \, \text{k}\Omega \times \sqrt{2}} \approx 70V
\]  

(61)

\[
V_2 = \frac{1.1 \times P_{\text{OUT}} \times \sqrt{2}}{2 \times \eta \times V_1} \times \frac{1}{N_{\text{CT}}} \times R_s = \frac{1.1 \times 300W \sqrt{2}}{0.92 \times 72V} \times \frac{1}{50} \times 33.2 \, \Omega \approx 2.458V
\]  

(62)

\[
R_{\text{IMO}} = \frac{V_2}{IMO} = \frac{2.458 \, \text{V}}{130 \, \mu \text{A}} \approx 18.9 \, \text{k}\Omega
\]  

(63)

Choose a standard resistor close to the calculated value:

\[ R_{\text{IMO}} = 19.6 \, \text{k}\Omega \]  

(64)

The current loop in a PFC converter is generally designed to crossover at between \( 1/10 \)th and \( 1/6 \)th the converter’s switching frequency. The current loop in this design example is going to be designed to crossover at \( 1/10 \)th of the single stage’s switching frequency. In order to properly compensate the current loop it is required to calculate the current loop’s power stage gain (\( G_{\text{PS}} \)) at the current loop’s crossover and properly select passive components \( R_{ZC1/2}, C_{ZC1/2} \) and \( C_{PC1/2} \):

\[
G_{\text{PS}} = \frac{V_{\text{OUT}} \times R_s \times \frac{1}{N_{\text{CT}}}}{2 \pi \times \frac{s}{10} \times L_{1\text{AVG}} \times \sqrt{V_{\text{RAMP}}}} = \frac{390 \, \text{V} \times 33.2 \, \Omega \times \frac{1}{50}}{2 \pi \times \frac{200 \, \text{kHz}}{10} \times 245 \, \mu \text{H} \times 4.0 \text{V}} \approx 2.1
\]  

(65)
Variable $g_m$ is the current amplifier Transconductance Current Amplifier Gain.

$$g_m = 100 \, \mu\text{S}$$ (66)

$$R_{ZC1} = R_{ZC2} = \frac{1}{g_m \times G_{PSC}} = \frac{1}{100 \, \mu\text{S} \times 2.1} = 4.8 \, \text{k}\Omega$$ (67)

$$C_{ZC1} = C_{ZC2} = \frac{1}{2\pi \frac{f_s}{10} \times R_{ZC}} = \frac{1}{2\pi \frac{200 \, \text{kHz}}{10} \times 4.8 \, \text{k}\Omega} \approx 1.7\text{nF}$$ (68)

$$C_{PC1} = C_{PC2} = \frac{1}{2\pi \frac{f_s}{2} \times R_{ZC}} = \frac{1}{2\pi \frac{200 \, \text{kHz}}{2} \times 4.8 \, \text{k}\Omega} \approx 333\text{pF}$$ (69)

Standard components close to the calculated values are chosen for the current loop compensation:

$$R_{ZC1} = 4.02 \, \text{k}\Omega, \ C_{ZC1} = 2.2 \, \text{nF}, \ C_{PC1} = 330 \, \text{pF}$$ (70)

Graphically Check Theoretical Current Loop Gain ($T_{cdB}(f)$) and loop phase ($\theta_c(f)$): From the plots in Figure 6 and Figure 7 it can be observed that the theoretical loop gain crossed over at roughly 20 kHz with a phase margin of roughly 39 degrees.

$$T_{cdB}(f) = 20\log\left(\frac{V_{OUT} \times R_S \times N_p}{N_S} \times g_m \times \frac{j \times 2\pi \times f \times R_{ZC} \times C_{ZC} + 1}{j \times 2\pi \times f \times L1 \times \Delta V_{RAMP} \times \left(j \times 2\pi \times f \times (C_{ZC} + C_{PC}) \times (C_{ZC} + C_{PC}) + 1\right)}\right)$$ (71)
12  **Soft Start**

To have a controlled soft start the $C_{SS}$ capacitor needs to be set to at least the same value as the $C_{ZV}$ capacitor or larger. This means the design has a minimum soft start time based on the $C_{ZV}$ capacitor

$$t_{SSMIN} = \frac{2.25 \text{V} \times C_{ZV}}{10 \text{ µA}} = \frac{2.25 \text{V} \times 1.5 \text{ µF}}{10 \text{ µA}} \approx 338 \text{ ms}$$

(72)

$$C_{SS} \geq C_{ZV}$$

(73)

The soft-start timing can be set with timing capacitor $C_{SS}$ once the amount of soft start time ($t_{SS}$) has been determined. Our original design requirement was to have 200 ms of soft-start time. The calculated capacitance needed for this soft-start time is less than the minimum required capacitance.

$$C_{SS} = \frac{10 \text{ µA} \times t_{SS}}{2.25 \text{V}} = \frac{10 \text{ µA} \times 200 \text{ ms}}{2.25 \text{V}} \approx 0.889 \text{ µF}$$

(74)

A $C_{SS}$ capacitor value equal to the $C_{ZV}$ capacitor was chosen for the design.

$$C_{SS} = 1.5 \text{ µF}$$

(75)

13  **Spread Spectrum Reduces EMI**

It has been shown that dithering the converter’s switching frequency can reduce EMI. Resistor $R_{RDM}$ and $C_{CDR}$ program the frequency dithering magnitude and rate. For this design the frequency dither magnitude ($f_{DM}$) was set to 30 kHz and the frequency dither rate ($f_{DR}$) was set to 10 kHz. The frequency will dither around the typical frequency programmed by resistor $R_{RT}$. In this example the frequency will dither from roughly 185 kHz to 215 kHz at a 10 kHz rate.

$$f_{DM} = 30 \text{ kHz}$$

(76)

$$f_{DR} = 10 \text{kHz}$$

(77)

$$R_{RDM} = \frac{937.5 \times 10^{6} \Omega}{30 \text{ kHz}} = \frac{937.5 \times 10^{6} \Omega}{f_{DM}} = 31.13 \text{ kΩ}$$

(78)

$$C_{CDR} = \frac{0.0667 \times 10^{-9} \text{F} \times R_{RDM}}{f_{RD}} = \frac{0.0667 \times 10^{-9} \text{F} \times 31.13 \text{ kΩ}}{10 \text{ kHz}} = 208 \text{ pF}$$

(79)

A standard resistor and capacitor are chosen for the design:

$$R_{RDM} = 31.6 \text{ kΩ}$$

(80)

$$C_{CDR} = 220 \text{pF}$$

(81)
14 Recommended PCB Device Layout

Interleaved PFC techniques dramatically reduce input and output ripple current caused by the PFC boost inductor, which allows the circuit to use smaller and less expensive filters. To maximize the benefits of interleaving, the output filter capacitor should be located after the two phases allowing the current of each phase to be combined together before entering the boost capacitor. Similar to other power management devices, when laying out the PCB it is important to use star grounding techniques and to keep filter and high frequency bypass capacitors as close to the device pins and ground pin as possible. To minimize the interference caused by magnetic coupling from the boost inductor, the device should be located at least one inch away from the boost inductor. It is also recommended that the device not be placed underneath magnetic elements. To verify the application a 300-W interleaved prototype was constructed and evaluated. This prototype consisted of mother board that was the power stage and a daughter board that consisted of the control circuitry. Refer to Figure 8 through Figure 13 for schematics and a recommended layout. The daughter board controller has two jumpers JP1 and JP2. If these jumpers are open the evaluation module is running with frequency dithering. If these jumpers are shorted frequency dither is disabled and the EVM can be synchronized through the sync input.

Figure 8. 300-W Prototype Daughter Board Controller Schematic
Figure 9. 300-W Prototype Mother Board Power Stage
Figure 10. Daughter Board Layout Front

Figure 11. Daughter Board Layout Back
Figure 12. Mother Board Layout Front

Figure 13. Mother Board Bottom
15 Efficiency Curves

A 300-W prototype was built based on the design information presented in this application note. The following graphs show the performance of this EVM.

15.1 Prototype Efficiency

Figure 14. Efficiency at VIN = 115V and VIN = 230V

Figure 15. Efficiency at VIN = 115V, VIN = 230V, and VIN = 265V RMS

Figure 16. Prototype Harmonic Content at VIN = 230 V, POUT = 300 W
15.2 Prototype Power Factor

Figure 17. Power Factor vs. % Output Power for VIN = 115V and 230V

Figure 18. Input Current and Output Ripple Voltage at Maximum Output Power
Ch2 = IIN, CH2 = VOUT

Figure 19. VIN = 85 V RMS

Figure 20. VIN = 265 V RMS
15.3 Inductor Ripple Current Cancellation, CH2=IL1, CH3=IL2, M1=IL1+IL2

Figure 21. \( V_{IN} = 85 \) V RMS, Peak of Line

Figure 22. \( V_{IN} = 265 \) V RMS, Peak of Line

Figure 23. \( V_{IN} = 265 \) V RMS, Line Voltage at Half the Output Voltage

Figure 24. \( V_{IN} = 85 \) V, \( P_{OUT} = 300 \) W
Figure 25. VIN = 265 V, POUT = 300 W
15.4 Recovery from Line Dropout, CH1= Rectified Line Voltage, CH2=IL1, CH3=IL2, CH4 = VOUT

Figure 26. Brownout at V\textsubscript{IN} = 115V, P\textsubscript{OUT} = 300 W

15.5 Startup, CH2 = IL1, CH3 = IL2, CH4 = V\textsubscript{OUT}

Figure 27. V\textsubscript{IN} = 85 V, P\textsubscript{OUT} = 300 W
Figure 28. V\textsubscript{IN} = 265 V, P\textsubscript{OUT} = 300 W
15.6 EMI Measurements

When dithering was applied to the EVM a 4.35dBuV reduction in the Quasi Peak (QP) measurement was observed. Note a filter was added to the front end of the EVM to clean up some of the noise to take EMI data. Depending on the filter the amount of EMI will vary. Also, this filter was not setup to pass EMI requirements but to show frequency dither reduced EMI.

![Figure 29. EMI Quasi Peak (QP) Measurement with out Frequency Dithering, No EMI Filter Present](Image)

![Figure 30. EMI Quasi Peak (QP) Measurement with Frequency Dithering, No EMI filter Present](Image)

16 References

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